Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/052,463	MATSUTANI, SHIGEKI	
Examiner	Art Unit	
Sheela C. Chawan	2625	

SEARCHED					
Class	Subclass	Date	Examiner		
382	173	6/16/2005	scc		
382	197	6/16/2005	scc		
382	305	6/16/2005	scc		
178	18.01	6/16/2005	scc		
434	155	6/16/2005	scc		

INT	INTERFERENCE SEARCHED					
Class	·Subclass	Date	Examiner			
382	119, 173	6/16/2005	scc			
382	305	6/16/2005	scc			
178	18.01	6/16/2005	scc			
439	155	6/16/05	scc			

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
EAST; US-PGPUB;USPAT;EPO;JPO; DERWENT;IBM-TDB.	6/16/2005	scc			
IEEE, INVENTER SEARCH.	6/16/2005	scc			
UP-DATE EAST SEARCH.	6/16/2001	scc			
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